Search Notes (continued)



Application/Control No.	. Applicant(s)/Patent under Reexamination
10/787,070	KAHNG ET AL.
Examiner	Art Unit
Sun J Lin	2825

F					
SEARCHED					
Class	Subclass	Date	Examiner		
716	21	7/21/2006	JSL		
716	19	7/21/2006	JSL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
716	19	7/21/2006	JSL	
716	21	7/21/2006	JSL	
:				

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDM]	7/21/2006	JSL
IEEE	7/21/2006	JSL
GOOGLE	7/21/2006	JSL
<del>-</del>		